

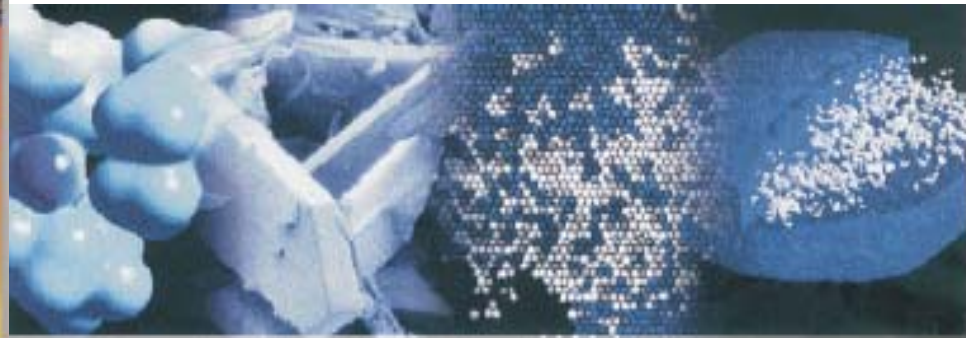
# Particle Size Measurement



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# Sieving

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# Sieving (cont..)

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- Each screen has smaller openings than the one above, usually in  $2^{1/n}$  series

$$\frac{D_1}{D_2} = \frac{D_2}{D_3} = \frac{D_3}{D_4} = \dots = \frac{D_{n-1}}{D_n} = \dots = \textit{constant}$$

*constant* =  $2^{1/4}$  (e.g. 0.0015, 0.0017, 0.0021 inch)

$2^{1/2}$  (e.g. 0.0015, 0.0021 inch)

# Sieving (cont..)

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**Table: Tyler Standard Screen Sizes**

Aperture (in) ( $2^{1/2}$ ) $\times 10^4$	Aperture (in) ( $2^{1/4}$ ) $\times 10^4$	Mesh Number	Wire Diameter (in)
29	35	170	0.0024
	29	200	0.0021
21	24	230	0.0016
	21	270	0.0016
15	17	325	0.0014
	15	400	0.0010

# Sieving (cont..)

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- ❑ The sample is placed on top of a series of screens with a lid above
- ❑ The stack of screens clamped into a shaker
- ❑ Shaking is continued for a fixed time

# Sieving (cont..)

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- As the sieves are shaken, the particles fall through them until a screen is reached in which the openings are too small for the particle to pass
- The sieves are removed
- The material held on each of the sieves is collected and weighed

# Sieving Efficiency

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$$\textit{Efficiency} = \frac{\text{percentage material actual passing}}{\text{percentage material capable of passing}}$$

# Factors Affecting the Efficiency

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- Rate of feeding
- Particle size
- Moisture
- Worn or damaged screens
- Blinding (clogging) of screens
- Electrostatic charge



# Screening terminology

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## □ Mesh

number of openings per linear inch.

For example

14 mesh will have 14 openings per inch

12 mesh will have 12 openings per inch

□ The higher the mesh number the smaller a particle has to be to pass through the column

# Screening terminology

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□ **Undersize**

□ **Oversize**

e.g. (-10+14) Tyler Mesh

□ **Screen aperture**

e.g. 0.0015 in, 0.0017 in, 0.0021 in

□ **Screen interval**

e.g.  $2^{1/2}$ ,  $2^{1/4}$

# Screening terminology

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## □ Diameter of a sieve fraction

e.g.

Size Range (Tyler Mesh)	Diameter (in)
-10+14	0.0555

# Methods of Graphic Presentation of Data

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- Histogram
- Fractional Distribution
- Cumulative Distribution

# Typical Screen Analysis Data

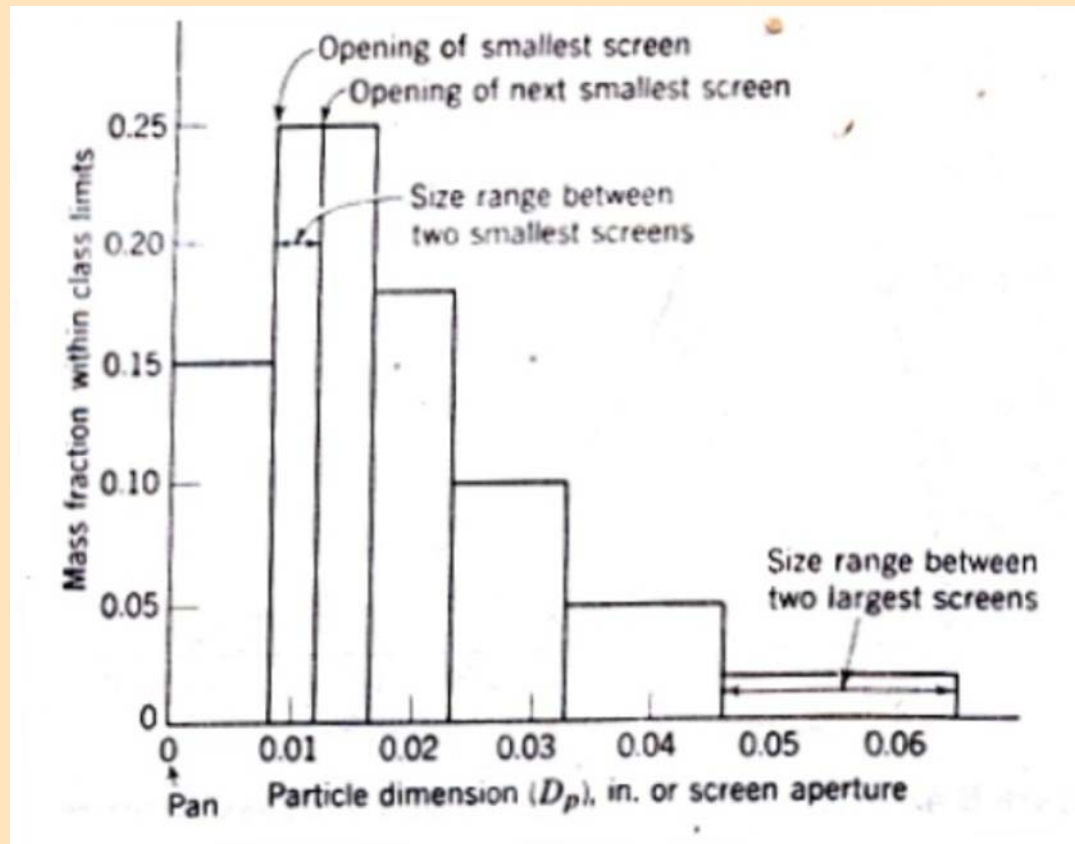
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Size Range	Mass Fraction Retained, wt%
-10+14	2
-14+20	5
-20+28	10
-28+35	18
-35+48	25
-48+65	25
-65	15

# Calculated Data

Size Range	Avg Particle Dia, in	Mass Fraction
-0.065+0.046	0.0555	0.02
-0.046+0.0328	0.0394	0.05
-0.0328+0.0232	0.0280	0.1
-0.0232+0.0164	0.0198	0.18
-0.0164+0.0116	0.0140	0.25
-0.0116+0.0082	0.0099	0.25
-0.0082		0.15

# Histogram



# Histogram

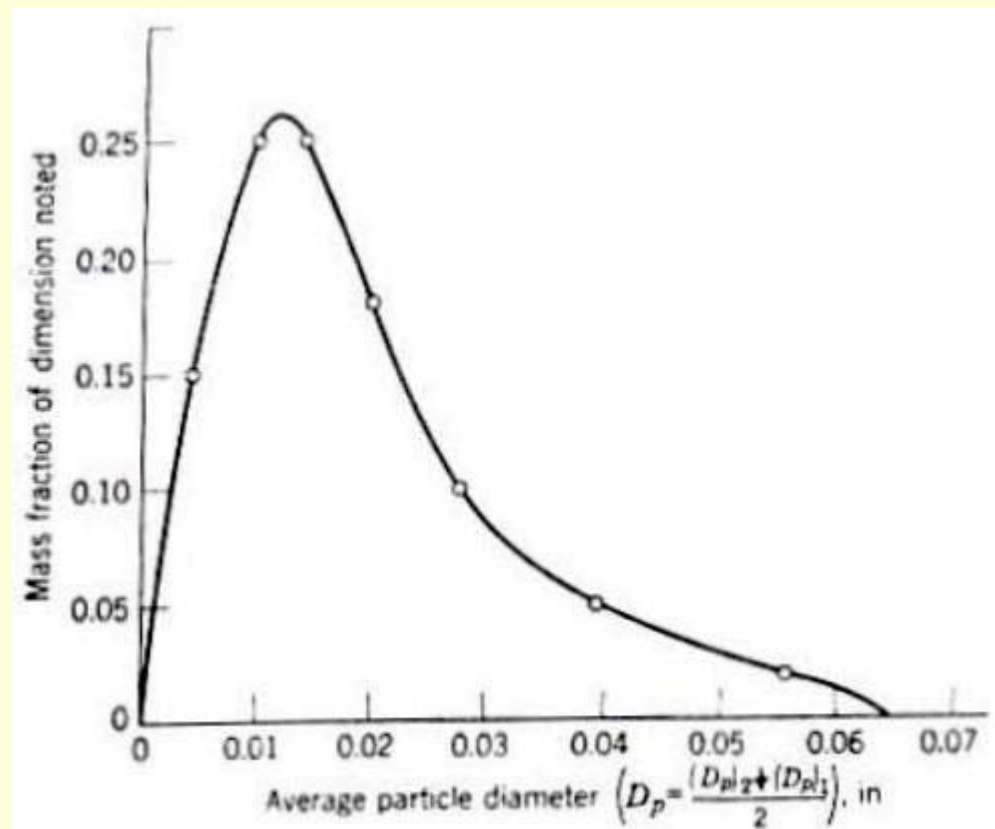
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- ❑ A bar graph
- ❑ Good pictorial method
- ❑ Shape greatly effected by sieve interval
- ❑ Grain size parameters (skewness, kurtosis) cannot be computed from histogram



# Fractional Distribution

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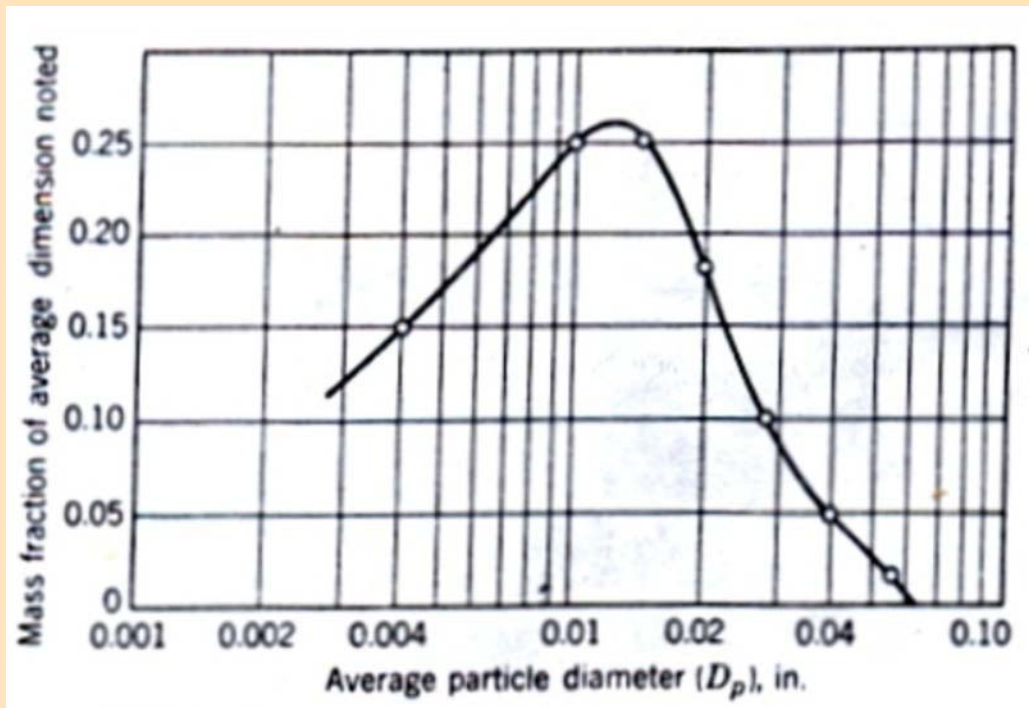
# Fractional Distribution

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- ❑ A “smoothed-out” histogram
- ❑ Good pictorial method
- ❑ Independent of sieve interval
- ❑ Grain size parameters cannot be computed from this curve

# Semi logarithmic Coordinate

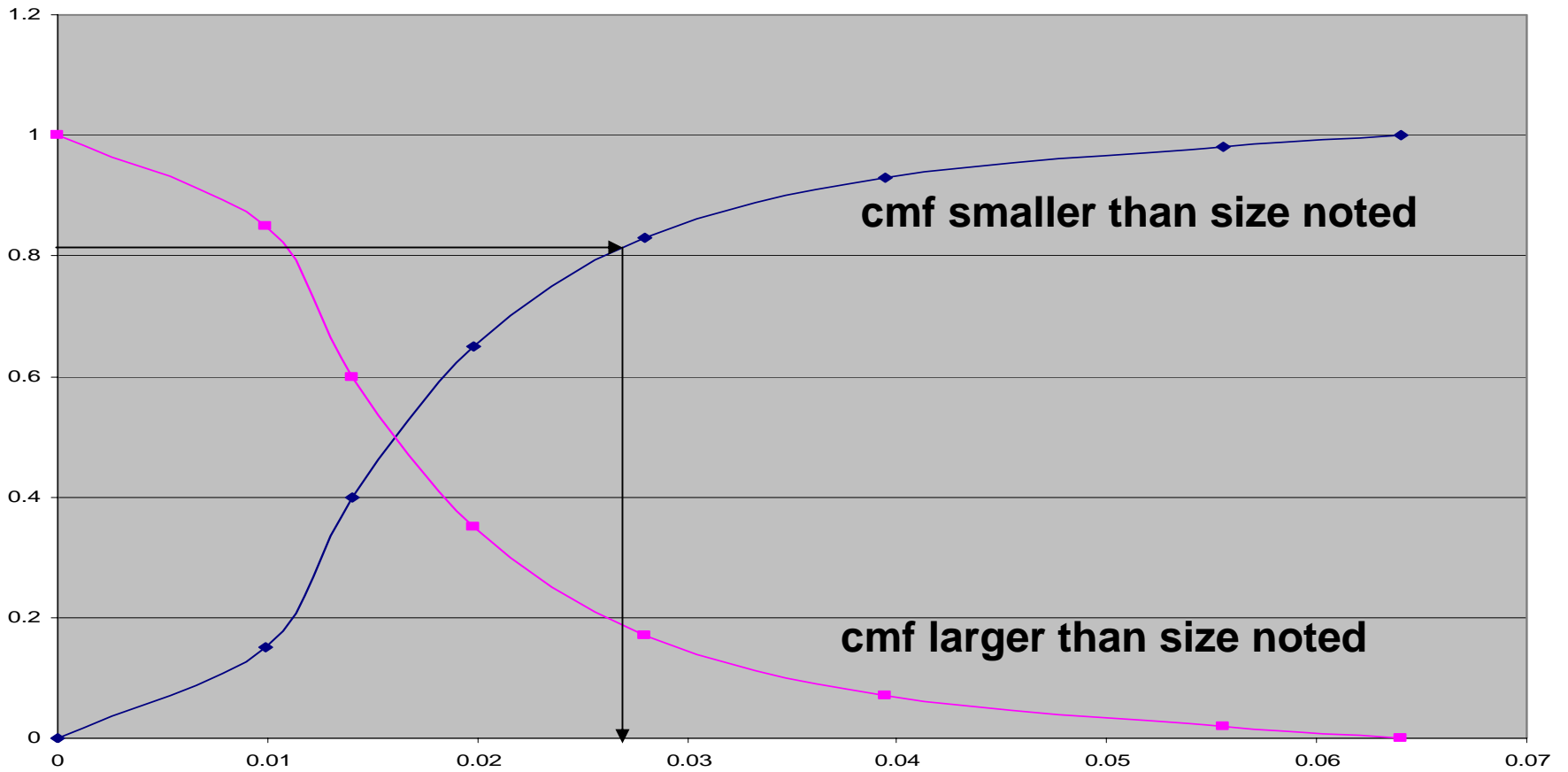
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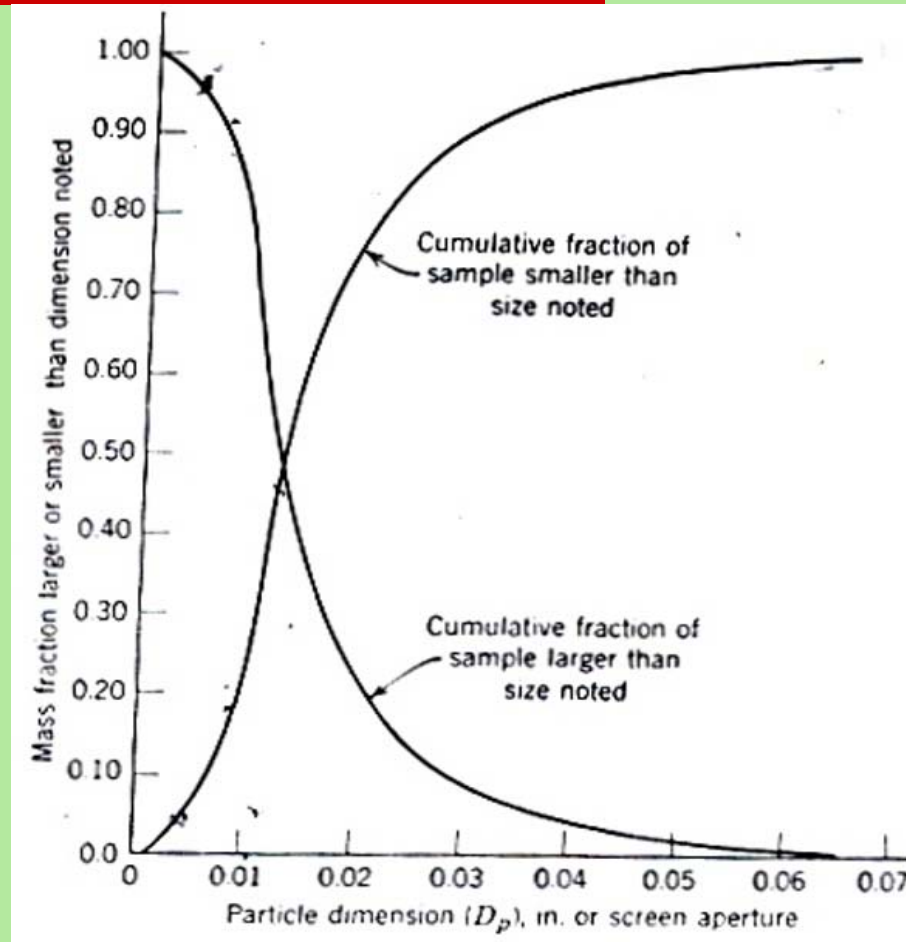
# Cumulative Distribution

Avg Particle Dia, in	Mass Fraction $x_i$	Cumulative MF smaller than size noted	Cumulative MF larger than size noted
		1	0
0.0555	0.02	0.98	0.02
0.0394	0.05	0.93	0.07
0.0280	0.1	0.83	0.17
0.0198	0.18	0.65	0.35
0.0140	0.25	0.4	0.6
0.0099	0.25	0.15	0.85
23 January, 2008	0.15	Particle Technology	1 20

# Cumulative Distribution



# Cumulative Distribution



# Cumulative Distribution

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- ❑ More difficult than histogram or frequency curve to interpret at a glance
- ❑ Independent of sieve interval
- ❑ Grain size parameters can be computed from this curve

# Summary of the Lecture

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- Sieving
- Different screening terminology
  - Undersize & Oversize
  - Screen aperture & Wire mesh etc.
- Graphic presentation of data
  - Histogram
  - Frequency curve
  - Cumulative distribution curve



# Reference

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- Foust *et al*: **Principles of Unit Operations**, second edition, John Wiley & Sons, Page#699-703